

Data Sheet September 16, 2009 FN6327.7

# High Voltage Input Precision, Low Noise FGA™ Voltage References

The ISL21009 FGA<sup>TM</sup> voltage references are extremely low power, high precision, and low noise voltage references fabricated on Intersil's proprietary Floating Gate Analog technology. The ISL21009 features very low noise (4.5 $\mu$ V<sub>P-P</sub> for 0.1Hz to 10Hz), low operating current (180 $\mu$ A, Max), and 3ppm/°C of temperature drift. In addition, the ISL21009 family features guaranteed initial accuracy as low as  $\pm 0.5$ mV.

This combination of high initial accuracy, low power and low output noise performance of the ISL21009 enables versatile high performance control and data acquisition applications with low power consumption.

### **Available Options**

| PART NUMBER     | V <sub>OUT</sub><br>OPTION<br>(V) | INITIAL<br>ACCURACY<br>(mV) | TEMPCO.<br>(ppm/°C) |
|-----------------|-----------------------------------|-----------------------------|---------------------|
| ISL21009BFB812Z | 1.250                             | ±0.5                        | 3                   |
| ISL21009CFB812Z | 1.250                             | ±1.0                        | 5                   |
| ISL21009DFB812Z | 1.250                             | ±2.0                        | 10                  |
| ISL21009BFB825Z | 2.500                             | ±0.5                        | 3                   |
| ISL21009CFB825Z | 2.500                             | ±1.0                        | 5                   |
| ISL21009DFB825Z | 2.500                             | ±2.0                        | 10                  |
| ISL21009BFB841Z | 4.096                             | ±0.5                        | 3                   |
| ISL21009CFB841Z | 4.096                             | ±1.0                        | 5                   |
| ISL21009DFB841Z | 4.096                             | ±2.0                        | 10                  |
| ISL21009BFB850Z | 5.000                             | ±0.5                        | 3                   |
| ISL21009CFB850Z | 5.000                             | ±1.0                        | 5                   |
| ISL21009DFB850Z | 5.000                             | ±2.0                        | 10                  |

#### **Features**

| • Output Voltages 1.250V, 2.500V, 4.096V, 5.000V    |
|---|
| • Initial Accuracy ±0.5mV, ±1.0mV, ±2.0mV           |
| • Input Voltage Range                               |
| • Output Voltage Noise                              |
| • Supply Current                                    |
| • Temperature Coefficient3ppm/°C, 5ppm/°C, 10ppm/°C |
| Output Current Capability Up to ±7.0mA              |
| Operating Temperature Range40°C to +125°C           |
| Package 8 Ld SOIC                                   |
|   |

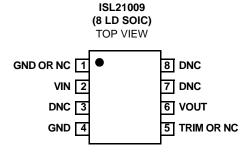
### **Applications**

• High Resolution A/Ds and D/As

Pb-Free (RoHS Compliant)

- · Digital Meters
- Bar Code Scanners
- · Basestations
- Battery Management/Monitoring
- Industrial/Instrumentation Equipment

#### **Pinout**



### Pin Descriptions

| PIN NUMBER | PIN NAME   | DESCRIPTION  |
|------------|------------|--|
| 1          | GND or NC  | Can be either Ground or No Connect                               |
| 2          | VIN        | Power Supply Input Connection                                    |
| 4          | GND        | Ground Connection  |
| 5          | TRIM or NC | Allows user trim typically ±2.5%. Leave Unconnected when unused. |
| 6          | VOUT       | Voltage Reference Output Connection                              |
| 3, 7, 8    | DNC        | Do Not Connect; Internal Connection – Must Be Left Floating      |

### **Ordering Information**

| PART NUMBER<br>(Notes 1, 2) | PART<br>MARKING | V <sub>OUT</sub> OPTION<br>(V) | GRADE            | TEMP. RANGE<br>(°C) | PACKAGE<br>(Pb-Free) | PKG. DWG. # |
|-----------------------------|-----------------|--------------------------------|------------------|---------------------|----------------------|-------------|
| ISL21009BFB812Z             | 21009BF Z12     | 1.250                          | ±0.5mV, 3ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009CFB812Z             | 21009CF Z12     | 1.250                          | ±1.0mV, 5ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009DFB812Z             | 21009DF Z12     | 1.250                          | ±2.0mV, 10ppm/°C | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009BFB825Z             | 21009BF Z25     | 2.500                          | ±0.5mV, 3ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009CFB825Z             | 21009CF Z25     | 2.500                          | ±1.0mV, 5ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009DFB825Z             | 21009DF Z25     | 2.500                          | ±2.0mV, 10ppm/°C | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009BFB841Z             | 21009BF Z41     | 4.096                          | ±0.5mV, 3ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009CFB841Z             | 21009CF Z41     | 4.096                          | ±1.0mV, 5ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009DFB841Z             | 21009DF Z41     | 4.096                          | ±2.0mV, 10ppm/°C | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009BFB850Z             | 21009BF Z50     | 5.000                          | ±0.5mV, 3ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009CFB850Z             | 21009CF Z50     | 5.000                          | ±1.0mV, 5ppm/°C  | -40 to +125         | 8 Ld SOIC            | M8.15       |
| ISL21009DFB850Z             | 21009DF Z50     | 5.000                          | ±2.0mV, 10ppm/°C | -40 to +125         | 8 Ld SOIC            | M8.15       |

#### NOTES:

These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte
tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil
Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD020.

<sup>2.</sup> Add "-TK" suffix for tape and reel. Please refer to TB347 for details on reel specifications.

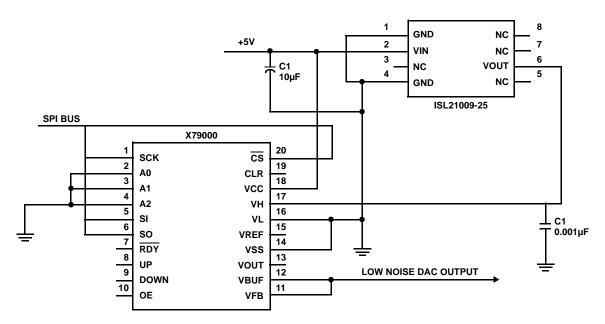


FIGURE 1. TYPICAL APPLICATION PRECISION 12-BIT SUB-RANGING DAC

#### **Absolute Voltage Ratings**

| Max Voltage V <sub>IN</sub> to GND        | 0.5V to +18V                  |
|---|-------------------------------|
| Max Voltage V <sub>OUT</sub> to GND (10s) | -0.5V to V <sub>OUT</sub> +1V |
| Voltage on "DNC" pins No connections perm | itted to these pins.          |
| ESD Ratings                               |                               |
| Human Body Model                          | 6kV                           |
| Charged Device Model                      | 2kV                           |

#### **Thermal Information**

| Thermal Resistance (Typical, Note 3)             | θ <sub>JA</sub> (°C/W) |
|--|------------------------|
| 8 Ld SOIC  | 115                    |
| Storage Temperature Range65°                     | C to +150°C            |
| Pb-free Reflow Profile (Note 4)se                | e link below           |
| http://www.intersil.com/pbfree/Pb-FreeReflow.asp |                        |

#### **Recommended Operating Conditions**

Temperature Range (Industrial) . . . . . . . . -40°C to +125°C

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typ values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore:  $T_J = T_C = T_A$ 

#### NOTES:

- 3. θ<sub>JA</sub> is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- 4. Post-reflow drift for the ISL21009 devices will range from 100μV to 1.0mV based on experimental results with devices tested in sockets and also on FR4 multi-layer PC boards. The design engineer must take this into account when considering the reference voltage after assembly.

### Common Electrical Specifications (ISL21009-12, -25, -41, -50) $T_A = -40$ °C to +125°C, $I_{OUT} = 0$ , unless otherwise specified.

| PARAMETER                            | DESCRIPTION  | CONDITIONS   | MIN  | TYP  | MAX  | UNIT              |
|--------------------------------------|--|--|------|------|------|-------------------|
| V <sub>OA</sub>                      | V <sub>OUT</sub> Accuracy @ T <sub>A</sub> = +25°C | ISL21009B  | -0.5 |      | +0.5 | mV                |
|                                      |  | ISL21009C  | -1.0 |      | +1.0 | mV                |
|                                      |  | ISL21009D  | -2.0 |      | +2.0 | mV                |
| TC V <sub>OUT</sub>                  | Output Voltage Temperature                         | ISL21009B  |      |      | 3    | ppm/°C            |
|                                      | Coefficient (Note 5)                               | ISL21009C  |      |      | 5    | ppm/°C            |
|                                      |  | ISL21009D  |      |      | 10   | ppm/°C            |
| I <sub>IN</sub>                      | Supply Current                                     |  |      | 95   | 180  | μΑ                |
| ΔV <sub>OUT</sub> / V <sub>OUT</sub> | Trim Range   |  | ±2.0 | ±2.5 |      | %                 |
| I <sub>SC</sub>                      | Short Circuit Current                              | T <sub>A</sub> = +25°C, V <sub>OUT</sub> tied to GND |      | 10   |      | mA                |
| t <sub>R</sub>                       | Turn-on Settling Time                              | V <sub>OUT</sub> = ±0.1%                             |      | 100  |      | μs                |
|                                      | Ripple Rejection                                   | f = 10kHz  |      | 60   |      | dB                |
| e <sub>N</sub>                       | Output Voltage Noise                               | $0.1Hz \le f \le 10Hz$                               |      | 4.5  |      | μV <sub>P-P</sub> |
| V <sub>N</sub>                       | Broadband Voltage Noise                            | $10Hz \le f \le 1kHz$                                |      | 2.2  |      | $\mu V_{RMS}$     |

### **Electrical Specifications (ISL21009-12, V\_{OUT} = 1.250V)** $V_{IN}$ = 5.0V, $T_A$ = -40°C to +125°C, $I_{OUT}$ = 0, unless otherwise specified.

| PARAMETER                       | DESCRIPTION                  | CONDITIONS                          | MIN | TYP   | MAX  | UNIT  |
|---------------------------------|------------------------------|-------------------------------------|-----|-------|------|-------|
| V <sub>OUT</sub>                | Output Voltage               |                                     |     | 1.250 |      | V     |
| V <sub>IN</sub>                 | Input Voltage Range          |                                     | 3.5 |       | 16.5 | V     |
| $\Delta V_{OUT}/\Delta V_{IN}$  | Line Regulation              | $3.5V \le V_{IN} \le 5.5V$          |     | 50    | 150  | μV/V  |
|                                 |                              | 5.5V ≤ V <sub>IN</sub> ≤ 16.5V      |     | 10    | 50   | μV/V  |
| $\Delta V_{OUT}/\Delta I_{OUT}$ | Load Regulation              | Sourcing: $0mA \le I_{OUT} \le 7mA$ |     | 10    | 50   | μV/mA |
|                                 |                              | Sinking: $-7mA \le I_{OUT} \le 0mA$ |     | 20    | 100  | μV/mA |
| $\Delta V_{OUT}/\Delta T_{A}$   | Thermal Hysteresis (Note 6)  | $\Delta T_A = +165$ °C              |     | 50    |      | ppm   |
| ΔV <sub>OUT</sub> /Δt           | Long Term Stability (Note 7) | T <sub>A</sub> = +25°C              |     | 50    |      | ppm   |

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### Electrical Specifications (ISL21009-25, $V_{OUT}$ = 2.50V) $V_{IN}$ = 5.0V, $T_A$ = -40°C to +125°C, $I_{OUT}$ = 0, unless otherwise specified.

| PARAMETER                       | DESCRIPTION                  | CONDITIONS   | MIN | TYP   | MAX  | UNIT  |
|---------------------------------|------------------------------|--|-----|-------|------|-------|
| V <sub>OUT</sub>                | Output Voltage               |  |     | 2.500 |      | V     |
| V <sub>IN</sub>                 | Input Voltage Range          |  | 3.5 |       | 16.5 | V     |
| $\Delta V_{OUT}/\Delta V_{IN}$  | Line Regulation              | $3.5 \text{V} \le \text{V}_{\text{IN}} \le 5.5 \text{V}$ |     | 50    | 150  | μV/V  |
|                                 |                              | 5.5V ≤ V <sub>IN</sub> ≤ 16.5V                           |     | 10    | 50   | μV/V  |
| $\Delta V_{OUT}/\Delta I_{OUT}$ | Load Regulation              | Sourcing: $0mA \le I_{OUT} \le 7mA$                      |     | 10    | 50   | μV/mA |
|                                 |                              | Sinking: $-7mA \le I_{OUT} \le 0mA$                      |     | 20    | 100  | μV/mA |
| $\Delta V_{OUT}/\Delta T_{A}$   | Thermal Hysteresis (Note 6)  | $\Delta T_A = +165$ °C                                   |     | 50    |      | ppm   |
| ΔV <sub>OUT</sub> /Δt           | Long Term Stability (Note 7) | T <sub>A</sub> = +25°C                                   |     | 50    |      | ppm   |

# Electrical Specifications (ISL21009-41, V<sub>OUT</sub> = 4.096V) V<sub>IN</sub> = 5.0V, T<sub>A</sub> = -40°C to +125°C, I<sub>OUT</sub> = 0 unless otherwise specified

| PARAMETER                       | DESCRIPTION                  | CONDITIONS                          | MIN | TYP   | MAX  | UNIT  |
|---------------------------------|------------------------------|-------------------------------------|-----|-------|------|-------|
| V <sub>OUT</sub>                | Output Voltage               |                                     |     | 4.096 |      | V     |
| V <sub>IN</sub>                 | Input Voltage Range          |                                     | 4.5 |       | 16.5 | V     |
| $\Delta V_{OUT}/\Delta V_{IN}$  | Line Regulation              | 4.5V ≤ V <sub>IN</sub> ≤ 16.5V      |     | 50    | 200  | μV/V  |
| $\Delta V_{OUT}/\Delta I_{OUT}$ | Load Regulation              | Sourcing: $0mA \le I_{OUT} \le 5mA$ |     | 20    | 100  | μV/mA |
|                                 |                              | Sinking: $-5mA \le I_{OUT} \le 0mA$ |     | 20    | 150  | μV/mA |
| $\Delta V_{OUT}/\Delta T_{A}$   | Thermal Hysteresis (Note 6)  | $\Delta T_A = +165$ °C              |     | 50    |      | ppm   |
| ΔV <sub>OUT</sub> /Δt           | Long Term Stability (Note 7) | T <sub>A</sub> = +25°C              |     | 50    |      | ppm   |

#### Electrical Specifications (ISL21009-50, $V_{OUT} = 5.0V$ ) $V_{IN} = 10.0V$ , $T_A = -40$ °C to +125°C, $I_{OUT} = 0$ unless otherwise specified.

| PARAMETER                       | DESCRIPTION                  | CONDITIONS                          | MIN | TYP   | MAX  | UNIT  |
|---------------------------------|------------------------------|-------------------------------------|-----|-------|------|-------|
| V <sub>OUT</sub>                | Output Voltage               |                                     |     | 5.000 |      | V     |
| V <sub>IN</sub>                 | Input Voltage Range          |                                     | 5.5 |       | 16.5 | V     |
| $\Delta V_{OUT}/\Delta V_{IN}$  | Line Regulation              | 5.5V ≤ V <sub>IN</sub> ≤ 16.5V      |     | 20    | 90   | μV/V  |
| $\Delta V_{OUT}/\Delta I_{OUT}$ | Load Regulation              | Sourcing: $0mA \le I_{OUT} \le 7mA$ |     | 10    | 100  | μV/mA |
|                                 |                              | Sinking: $-7mA \le I_{OUT} \le 0mA$ |     | 20    | 150  | μV/mA |
| $\Delta V_{OUT}/\Delta T_{A}$   | Thermal Hysteresis (Note 6)  | $\Delta T_A = +165$ °C              |     | 50    |      | ppm   |
| ΔV <sub>OUT</sub> /Δt           | Long Term Stability (Note 7) | T <sub>A</sub> = +25°C              |     | 50    |      | ppm   |

#### NOTES:

- 5. Over the specified temperature range. Temperature coefficient is measured by the box method whereby the change in V<sub>OUT</sub> is divided by the temperature range; in this case, -40°C to +125°C = +165°C.
- 6. Thermal Hysteresis is the change of  $V_{OUT}$  measured @  $T_A$  = +25°C after temperature cycling over a specified range,  $\Delta T_A$ .  $V_{OUT}$  is read initially at  $T_A$  = +25°C for the device under test. The device is temperature cycled and a second  $V_{OUT}$  measurement is taken at +25°C. The difference between the initial  $V_{OUT}$  reading and the second  $V_{OUT}$  reading is then expressed in ppm. For  $\Delta$   $T_A$  = +165°C, the device under test is cycled from +25°C to +125°C to -40°C to +25°C.
- 7. Long term drift is logarithmic in nature and diminishes over time. Drift after the first 1000 hours will be approximately 10ppm/√(1kHrs).

### Typical Performance Curves (ISL21009-12) (REXT = 100kΩ)

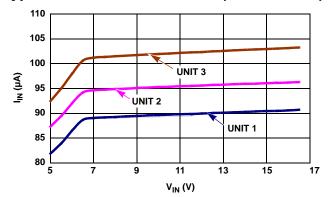


FIGURE 2. I<sub>IN</sub> vs V<sub>IN</sub>, 3 UNITS

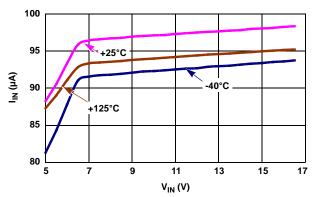


FIGURE 3.  $I_{IN}$  vs  $V_{IN}$ , 3 TEMPERATURES

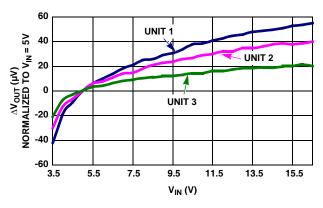


FIGURE 4. LINE REGULATION, 3 UNITS

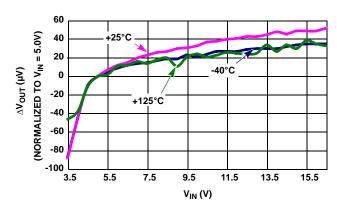
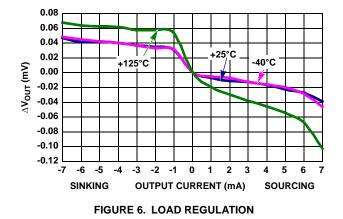
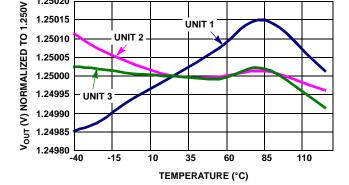


FIGURE 5. LINE REGULATION OVER-TEMPERATURE





1.25020

FIGURE 7. V<sub>OUT</sub> vs TEMPERATURE, 3 UNITS

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### Typical Performance Curves (ISL21009-12) (R<sub>EXT</sub> = 100kΩ) (Continued)

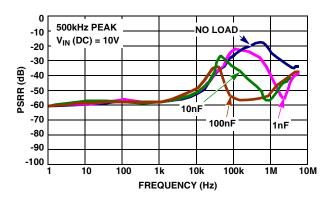


FIGURE 8. PSRR AT DIFFERENT CAPACITIVE LOADS

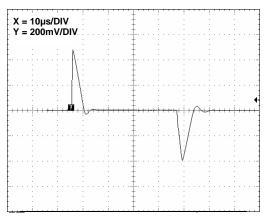


FIGURE 9. LINE TRANSIENT RESPONSE, NO CAPACITIVE LOAD

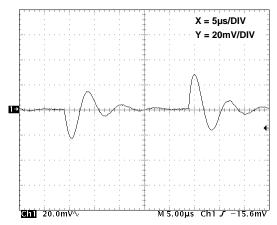


FIGURE 10. LINE TRANSIENT RESPONSE, 0.001µF LOAD CAPACITANCE

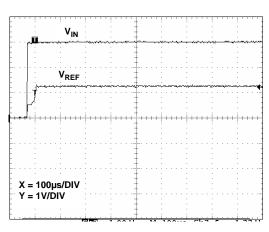


FIGURE 11. TURN-ON TIME

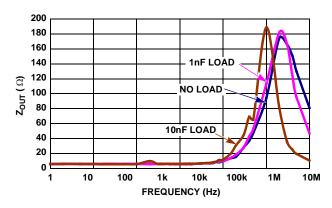


FIGURE 12. Z<sub>OUT</sub> vs FREQUENCY

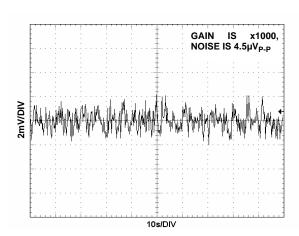


FIGURE 13.  $V_{OUT}$  NOISE, 0.1Hz TO 10Hz

### Typical Performance Curves (ISL21009-12) (R<sub>EXT</sub> = 100kΩ) (Continued)

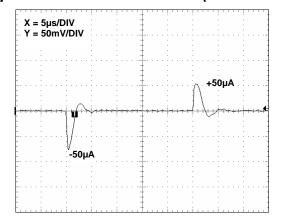


FIGURE 14. LOAD TRANSIENT RESPONSE

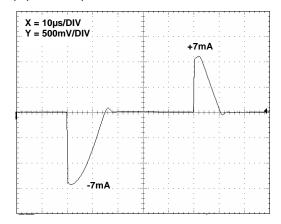


FIGURE 15. LOAD TRANSIENT RESPONSE

### Typical Performance Curves (ISL21009-25) (REXT = 100k\(\Omega))

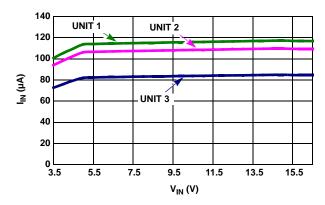


FIGURE 16.  $I_{IN}$  vs  $V_{IN}$ , 3 UNITS

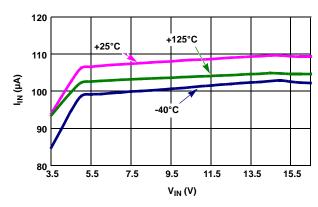


FIGURE 17. I<sub>IN</sub> vs V<sub>IN</sub>, 3 TEMPERATURES

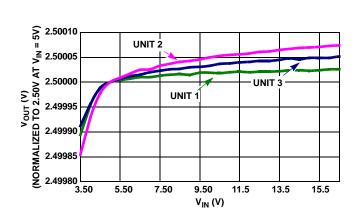


FIGURE 18. LINE REGULATION

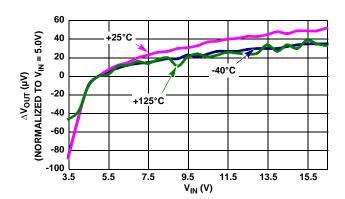


FIGURE 19. LINE REGULATION OVER-TEMPERATURE

### Typical Performance Curves (ISL21009-25) (R<sub>EXT</sub> = 100kΩ) (Continued)

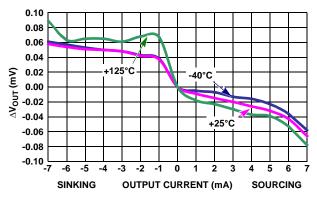


FIGURE 20. LOAD REGULATION

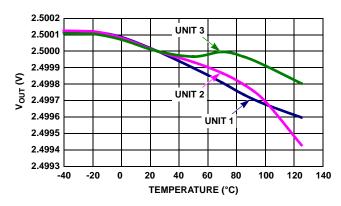


FIGURE 21. V<sub>OUT</sub> vs TEMPERATURE

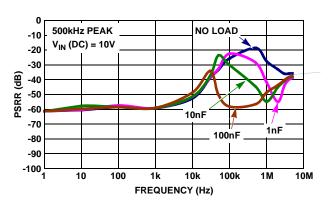


FIGURE 22. PSRR AT DIFFERENT CAPACITIVE LOADS

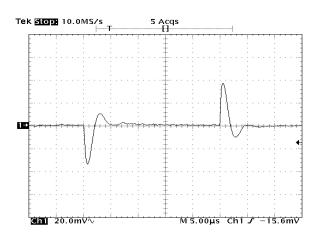


FIGURE 23. LINE TRANSIENT RESPONSE, NO CAPACITIVE LOAD

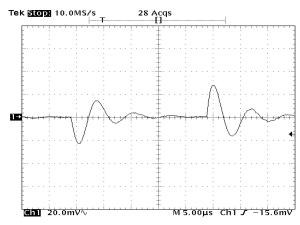


FIGURE 24. LINE TRANSIENT RESPONSE, 0.001µF LOAD CAPACITANCE

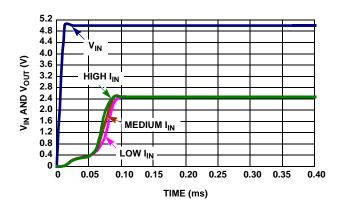


FIGURE 25. TURN-ON TIME

### Typical Performance Curves (ISL21009-25) (R<sub>EXT</sub> = 100kΩ) (Continued)

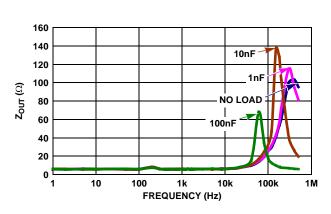


FIGURE 26.  $Z_{OUT}$  vs FREQUENCY

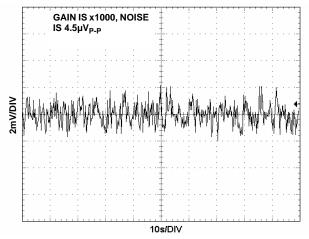


FIGURE 27.  $V_{OUT}$  NOISE, 0.1Hz TO 10Hz

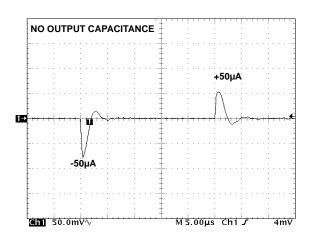


FIGURE 28. LOAD TRANSIENT RESPONSE

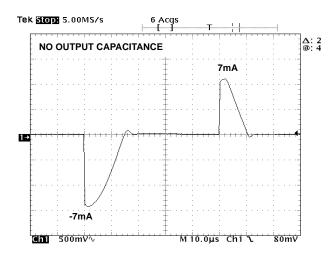


FIGURE 29. LOAD TRANSIENT RESPONSE

### Typical Performance Curves (ISL21009-41) (REXT = 100k\(\Omega))

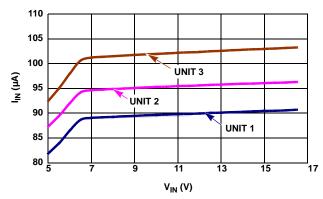


FIGURE 30.  $I_{\rm IN}$  vs  $V_{\rm IN}$ , 3 UNITS

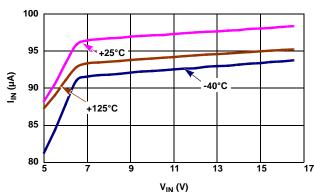


FIGURE 31.  $I_{\text{IN}}$  vs  $V_{\text{IN}}$ , 3 TEMPERATURES

### Typical Performance Curves (ISL21009-41) (R<sub>EXT</sub> = 100kΩ) (Continued)

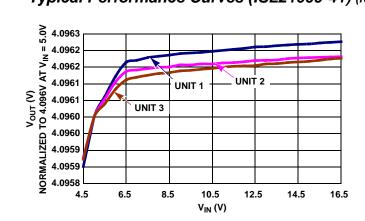


FIGURE 32. LINE REGULATION, 3 UNITS

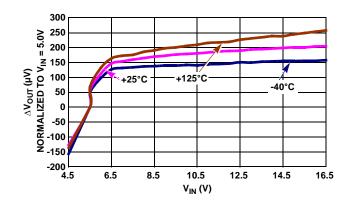
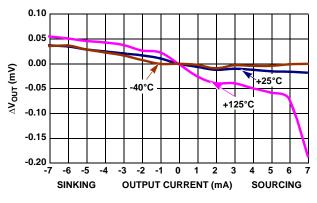


FIGURE 33. LINE REGULATION OVER-TEMPERATURE



**FIGURE 34. LOAD REGULATION** 

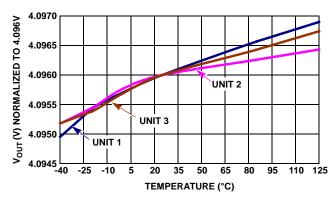


FIGURE 35. V<sub>OUT</sub> vs TEMPERATURE

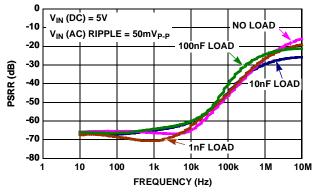


FIGURE 36. PSRR AT DIFFERENT CAPACITIVE LOADS

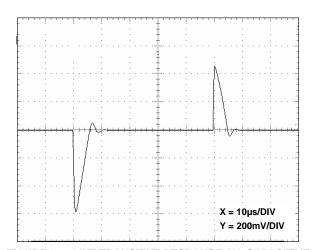


FIGURE 37. LINE TRANSIENT RESPONSE, NO CAPACITIVE LOAD

## Typical Performance Curves (ISL21009-41) ( $R_{EXT} = 100k\Omega$ ) (Continued)

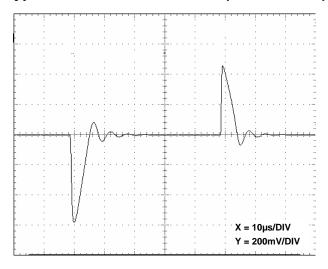


FIGURE 38. LINE TRANSIENT RESPONSE, 0.001µF LOAD CAPACITANCE

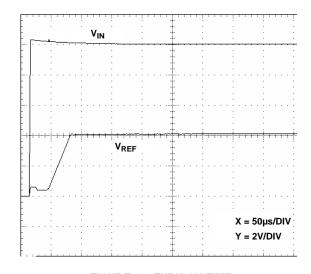


FIGURE 39. TURN-ON TIME

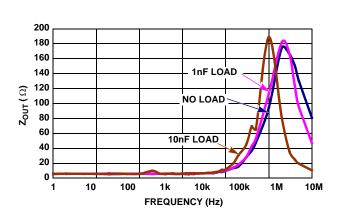


FIGURE 40. Z<sub>OUT</sub> vs FREQUENCY

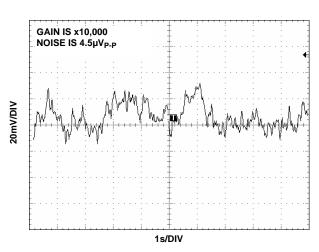


FIGURE 41.  $V_{OUT}$  NOISE, 0.1Hz TO 10Hz

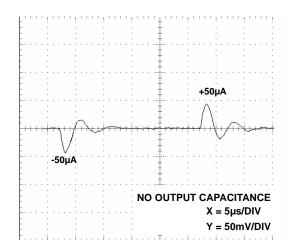


FIGURE 42. LOAD TRANSIENT RESPONSE

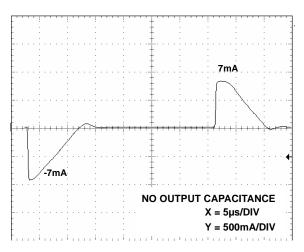


FIGURE 43. LOAD TRANSIENT RESPONSE

### Typical Performance Curves (ISL21009-50) (REXT = 100kΩ)

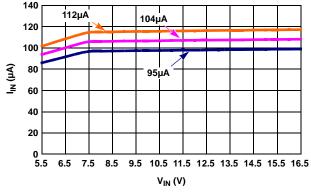


FIGURE 44.  $I_{\rm IN}$  vs  $V_{\rm IN}$ , 3 UNITS

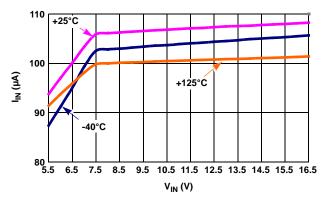


FIGURE 45. I<sub>IN</sub> vs V<sub>IN</sub>, 3 TEMPERATURES

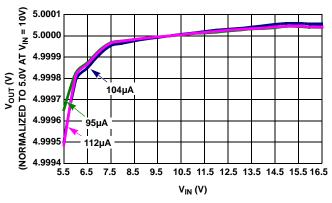


FIGURE 46. LINE REGULATION

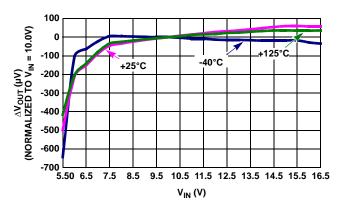
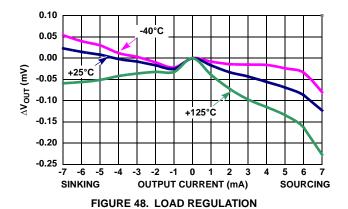


FIGURE 47. LINE REGULATION OVER-TEMPERATURE



13

### Typical Performance Curves (ISL21009-50) (R<sub>EXT</sub> = 100kΩ) (Continued)

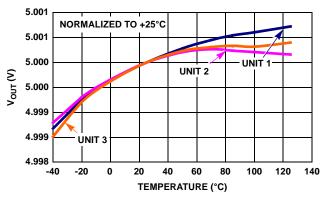


FIGURE 49. V<sub>OUT</sub> vs TEMPERATURE

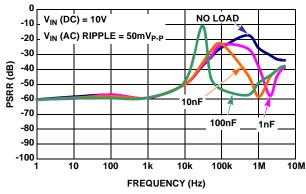


FIGURE 50. PSRR AT DIFFERENT CAPACITIVE LOADS

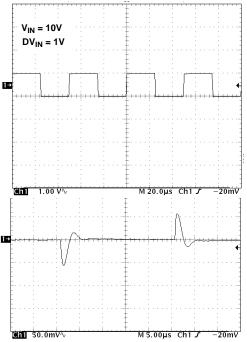


FIGURE 51. LINE TRANSIENT RESPONSE, NO CAPACITIVE

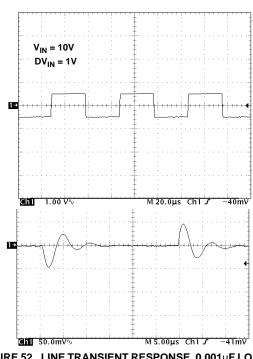


FIGURE 52. LINE TRANSIENT RESPONSE,  $0.001\mu F$  LOAD CAPACITANCE

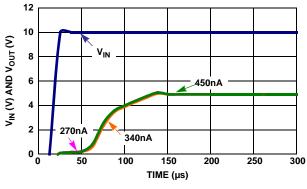


FIGURE 53. TURN-ON TIME

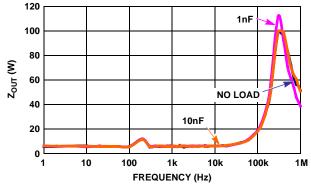


FIGURE 54. Z<sub>OUT</sub> vs FREQUENCY

### Typical Performance Curves (ISL21009-50) (R<sub>EXT</sub> = 100kΩ) (Continued)

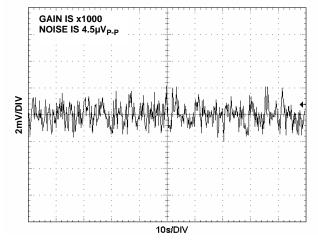


FIGURE 55. V<sub>OUT</sub> NOISE, 0.1Hz TO 10Hz

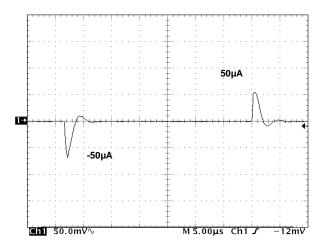
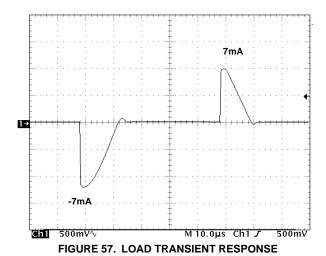


FIGURE 56. LOAD TRANSIENT RESPONSE



### **Applications Information**

#### FGA Technology

The ISL21009 voltage reference uses floating gate technology to create references with very low drift and supply current. Essentially the charge stored on a floating gate cell is set precisely in manufacturing. The reference voltage output itself is a buffered version of the floating gate voltage. The resulting reference device has excellent characteristics, which are unique in the industry: very low temperature drift, high initial accuracy, and almost zero supply current. Also, the reference voltage itself is not limited by voltage bandgaps or zener settings, so a wide range of reference voltages can be programmed (standard voltage settings are provided, but customer-specific voltages are available).

The process used for these reference devices is a floating gate CMOS process and the amplifier circuitry uses CMOS transistors for amplifier and output transistor circuitry. While providing excellent accuracy, there are limitations in output noise level and load regulation due to the MOS device characteristics. These limitations are addressed with circuit techniques discussed in other sections.

#### Micropower Operation

The ISL21009 consumes extremely low supply current due to the proprietary FGA technology. Low noise performance is achieved using optimized biasing techniques. Supply current is typically 95µA and noise is 4.5µV<sub>P-P</sub> benefitting precision, low noise portable applications such as handheld meters and instruments.

Data Converters in particular can utilize the ISL21009 as an external voltage reference. Low power DAC and ADC circuits will realize maximum resolution with lowest noise.

#### **Board Mounting Considerations**

For applications requiring the highest accuracy, board mounting location should be reviewed. The device uses a plastic SOIC package, which will subject the die to mild stresses when the Printed Circuit (PC) board is heated and cooled, slightly changing the shape. Placing the device in areas subject to slight twisting can cause degradation of the accuracy of the reference voltage due to these die stresses. It is normally best to place the device near the edge of a board, or the shortest side, as the axis of bending is most limited at that location. Mounting the device in a cutout also minimizes flex. Obviously mounting the device on flexprint or extremely thin PC material will likewise cause loss of reference accuracy.

#### **Board Assembly Considerations**

FGA references provide high accuracy and low temperature drift but some PC board assembly precautions are necessary. Normal Output voltage shifts of 100μV to 1mV can be expected with Pb-free reflow profiles or wave solder on multi-layer FR4 PC boards. Precautions should be taken to avoid excessive heat or extended exposure to high reflow or wave solder temperatures, this may reduce device initial accuracy.

Post-assembly x-ray inspection may also lead to permanent changes in device output voltage and should be minimized or avoided. If x-ray inspection is required, it is advisable to monitor the reference output voltage to verify excessive shift has not occurred. If large amounts of shift are observed, it is best to add an X-ray shield consisting of thin zinc (300µm) sheeting to allow clear imaging, yet block x-ray energy that affects the FGA reference.

#### Special Applications Considerations

In addition to post-assembly examination, there are also other X-ray sources that may affect the FGA reference long term accuracy. Airport screening machines contain X-rays and will have a cumulative effect on the voltage reference output accuracy. Carry-on luggage screening uses low level X-rays and is not a major source of output voltage shift, although if a product is expected to pass through that type of screening over 100 times it may need to consider shielding with copper or aluminum. Checked luggage X-rays are higher intensity and can cause output voltage shift in much fewer passes, so devices expected to go through those machines should definitely consider shielding. Note that just two layers of 1/2 ounce copper planes will reduce the received dose by over 90%. The leadframe for the device which is on the bottom also provides similar shielding.

If a device is expected to pass through luggage X-ray machines numerous times, it is advised to mount a 2-layer (minimum) PC board on the top, and along with a ground

plane underneath will effectively shield it from from 50 to 100 passes through the machine. Since these machines vary in X-ray dose delivered, it is difficult to produce an accurate maximum pass recommendation.

#### Noise Performance and Reduction

The output noise voltage in a 0.1Hz to 10Hz bandwidth is typically 4.5 $\mu$ V<sub>P-P</sub>. The noise measurement is made with a bandpass filter made of a 1-pole high-pass filter with a corner frequency at 0.1Hz and a 2-pole low-pass filter with a corner frequency (3dB) at 8.2Hz to create a filter with a 9.9Hz bandwidth. Noise in the 10Hz to 1kHz bandwidth is approximately 2.2 $\mu$ V<sub>P-P</sub> with no capacitance on the output. This noise measurement is made with a 2 decade bandpass filter made of a 1-pole high-pass filter with a corner frequency at 1/10 of the center frequency and 1-pole low-pass filter with a corner frequency at 10x the center frequency. Load capacitance up to 1000pF can be added but will result in only marginal improvements in output noise and transient response.

The output stage of the ISL21009 does not drive heavily capacitive loads well, so for load capacitances above 0.001  $\mu F$ , the noise reduction network shown in Figure 58 is recommended. This network reduces noise significantly over the full bandwidth. Noise is reduced to less than  $15\mu V_{P-P}$  from 1Hz to 1kHz using this network with a 0.01  $\mu F$  capacitor and a 2k $\Omega$  resistor in series with a 10  $\mu F$  capacitor. Also, transient response is improved. The 0.01  $\mu F$  value can be increased for better load transient response with little sacrifice in output stability.

Higher output capacitor values can be used without the RC network to address transient loads without stability problems, although there will be more overshoot an longer settling times with values up to  $1.0\mu F$ . Output capacitor values greater than  $1.0\mu F$  are not recommended for the ISL21009.

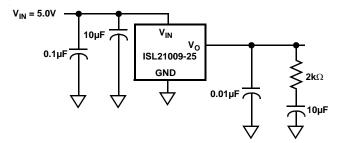


FIGURE 58. HANDLING HIGH LOAD CAPACITANCE

#### **Turn-On Time**

The ISL21009 devices have low supply current and thus, the time to bias up internal circuitry to final values will be longer than with higher power references. Normal turn-on time is typically 100 $\mu$ s, as shown in Figure 25. Circuit design must take this into account when looking at power-up delays or sequencing.

#### Temperature Coefficient

The limits stated for temperature coefficient (tempco) are governed by the method of measurement. The overwhelming standard for specifying the temperature drift of a reference is to measure the reference voltage at two temperatures, take the total variation,  $(V_{HIGH}-V_{LOW}),$  and divide by the temperature extremes of measurement  $(T_{HIGH}-T_{LOW}).$  The result is divided by the nominal reference voltage (at T = +25°C) and multiplied by  $10^6$  to yield ppm/°C. This is the "Box" method for specifying temperature coefficient.

### Output Voltage Adjustment

The output voltage can be adjusted up or down by 2.5% by placing a potentiometer from  $V_{OUT}$  to GND and connecting the wiper to the TRIM pin. The TRIM input is high impedance so no series resistance is needed. The resistor in the potentiometer should be a low tempco (<50ppm/°C) and the resulting voltage divider should have very low tempco <5ppm/°C. A digital potentiometer such as the ISL95810 provides a low tempco resistance and excellent resistor and tempco matching for trim applications.

### **Typical Application Circuits**

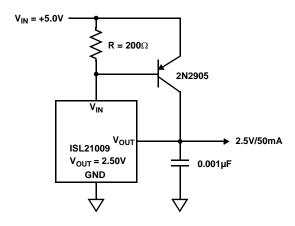


FIGURE 59. PRECISION 2.5V, 50mA REFERENCE

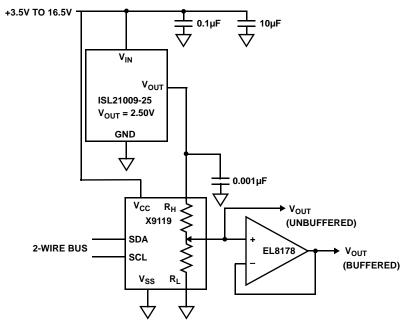


FIGURE 60. 2.5V FULL SCALE LOW-DRIFT, LOW NOISE, 10-BIT ADJUSTABLE VOLTAGE SOURCE

## Typical Application Circuits (Continued)

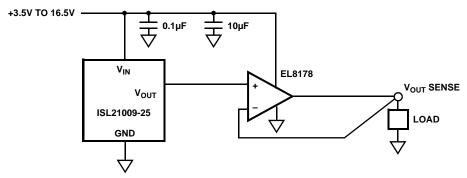


FIGURE 61. KELVIN SENSED LOAD

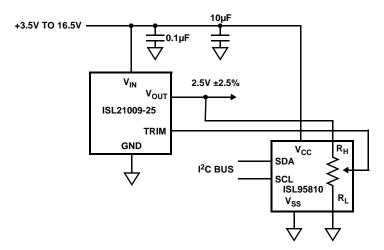
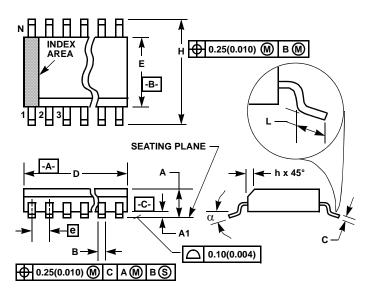


FIGURE 62. OUTPUT ADJUSTMENT USING THE TRIM PIN

### Small Outline Plastic Packages (SOIC)



#### NOTES:

- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M8.15 (JEDEC MS-012-AA ISSUE C) 8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

|        | INCHES |        | MILLIM | MILLIMETERS |       |  |
|--------|--------|--------|--------|-------------|-------|--|
| SYMBOL | MIN    | MAX    | MIN    | MAX         | NOTES |  |
| Α      | 0.0532 | 0.0688 | 1.35   | 1.75        | -     |  |
| A1     | 0.0040 | 0.0098 | 0.10   | 0.25        | -     |  |
| В      | 0.013  | 0.020  | 0.33   | 0.51        | 9     |  |
| С      | 0.0075 | 0.0098 | 0.19   | 0.25        | -     |  |
| D      | 0.1890 | 0.1968 | 4.80   | 5.00        | 3     |  |
| Е      | 0.1497 | 0.1574 | 3.80   | 4.00        | 4     |  |
| е      | 0.050  | BSC    | 1.27   | BSC         | -     |  |
| Н      | 0.2284 | 0.2440 | 5.80   | 6.20        | -     |  |
| h      | 0.0099 | 0.0196 | 0.25   | 0.50        | 5     |  |
| L      | 0.016  | 0.050  | 0.40   | 1.27        | 6     |  |
| N      | 8      | 3      | 8      |             | 7     |  |
| а      | 0°     | 8°     | 0°     | 8°          | -     |  |

Rev. 1 6/05

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